DATASHEET

SISD0600ED120i20

ED-Type phase leg IGBT module

V_{CE} = 1200 V
I_C = 2 x 600 A

- *i20* ultra-low loss fine pattern Trench IGBT chipset
- Baseplate isolation with efficient Al_2O_3 ceramic
- Cu baseplate for low thermal resistance
- Industry standard package

Maximum ratings[1]

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNIT
Collector-emitter voltage	V_{CES}	V_{GE} = 0 V, T_{vj} = 25 °C		1200	V
DC collector current	I_C	T_C = 120 °C, T_{vj} = 175 °C		600	A
Peak collector current	I_{CM}	t_p = 1 ms		1200	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	T_C = 25 °C, T_{vj} = 175 °C, per switch		3260	W
DC forward current	I_F			600	A
Peak forward current	I_{FRM}	t_p = 1 ms		1200	A
Surge current	I_{FSM} I^2t	V_R = 0 V, T_{vj} = 150 °C, t_p = 10 ms, half-sinewave		2750 37500	A A^2s
Isolation voltage	V_{isol}	1 min, f = 50 Hz		3400	V
Junction operating temperature	$T_{vj(op)}$		-40	175[2]	°C
Case temperature	T_C		-40	125[3]	°C
Storage temperature	T_{stg}		-40	125	°C
Mounting torques[4]	M_S	Base-heatsink, M5 screws	3	6	Nm
	M_{t1}	Main terminals, M6 screws	3	6	Nm

---

[1] Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747
[2] $T_{vj(op)}$ > 150°C allowed for overload conditions, in maximum for 60s and less than 20% of operation time
[3] For UL1557 compliance T_{Cmax} must be limited to 125°C
[4] For details, please refer to the mounting instructions

IGBT[5]

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNIT
Collector(-emitter) breakdown voltage	$V_{(BR)CES}$	V_{GE} = 0 V, I_C = 10 mA, T_{vj} = 25°C		1200			V
Collector-emitter saturation voltage [6]	V_{CEsat}	I_c = 600 A, V_{GE} = 15 V	T_{vj} = 25 °C		1.5	1.9	V
			T_{vj} = 125 °C		1.7		V
			T_{vj} = 175 °C		1.8		V
Collector cut-off current	I_{CES}	V_{CE} = 1200 V, V_{GE} = 0 V	T_{vj} = 25 °C			1	mA
			T_{vj} = 125 °C		1		mA
			T_{vj} = 175 °C		20		mA
Gate leakage current	I_{GES}	V_{CE} = 0 V, V_{GE} = ±20 V		-0.5		0.5	µA
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C = 30 mA, V_{CE} = V_{GE}, T_{vj} = 25°C		5	6.2	7.5	V
Gate charge	Q_G	I_C = 600 A, V_{CE} = 600 V, V_{GE} = -15 V .. 15 V			5.3		µC
Input capacitance	C_{ies}	V_{CE} = 25 V, V_{GE} = 0 V, f = 1 MHz, T_{vj} = 25 °C			44		nF
Output capacitance	C_{oes}				3.9		nF
Reverse tansfer capacitance	C_{res}				2.1		nF
Internal gate resistor	R_{Gint}	Per switch			1.2		Ω
Turn-on delay time	$t_{d(on)}$	V_{CC} = 600 V, I_C = 600 A, R_G = 0.47 Ω, V_{GE} = ± 15 V, L_s = 30 nH, inductive load	T_{vj} = 25 °C		120		ns
			T_{vj} = 125 °C		145		ns
			T_{vj} = 175 °C		155		ns
Rise time	t_r		T_{vj} = 25 °C		60		ns
			T_{vj} = 125 °C		67		ns
			T_{vj} = 175 °C		70		ns
Turn-off delay time	$t_{d(off)}$	V_{CC} = 600 V, I_C = 600 A, R_G = 1.5 Ω, V_{GE} = ± 15 V, L_s = 30 nH, inductive load	T_{vj} = 25 °C		575		ns
			T_{vj} = 125 °C		685		ns
			T_{vj} = 175 °C		735		ns
Fall time	t_f		T_{vj} = 25 °C		165		ns
			T_{vj} = 125 °C		290		ns
			T_{vj} = 175 °C		335		ns
Turn-on switching energy	E_{on}	V_{CC} = 600 V, I_C = 600 A, R_G = 0.47 Ω, V_{GE} = ± 15 V, L_s = 30 nH, inductive load	T_{vj} = 25 °C		20		mJ
			T_{vj} = 125 °C		50		mJ
			T_{vj} = 175 °C		73		mJ
Turn-off switching energy	E_{off}	V_{CC} = 600 V, I_C = 600 A, R_G = 1.5 Ω, V_{GE} = ± 15 V, L_s = 30 nH, inductive load	T_{vj} = 25 °C		66		mJ
			T_{vj} = 125 °C		90		mJ
			T_{vj} = 175 °C		100		mJ
Short circuit current	I_{SC}	t_{pcs} ≤ 10 µs, V_{GE} = 15 V, T_{vj} = 175 °C, V_{CC} = 800 V, $_{VCEM\ Chip}$ ≤ 1200 V			2000		A

---

[5] Characteristic values according to IEC 60747-9

[6] Collector-emitter saturation voltage is given at chip-level

Diode[7]

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNIT
Forward voltage[8]	V_F	I_F = 600 A	T_{vj} = 25 °C		1.85	2.3	V
			T_{vj} = 125 °C		1.95		V
			T_{vj} = 175 °C		2.00		V
Peak reverse recovery current	I_{RM}	V_R = 600 V, I_F = 600 A, dI/dt = 9000 A/µs (175 °C), R_G = 0.47 Ω, V_{GE} = ± 15 V, L_s = 30 nH, inductive load	T_{vj} = 25 °C		485		A
			T_{vj} = 125 °C		570		A
			T_{vj} = 175 °C		585		A
Recovery charge	Q_{rr}		T_{vj} = 25 °C		53		µC
			T_{vj} = 125 °C		75		µC
			T_{vj} = 175 °C		133		µC
Reverse recovery time	t_{rr}		T_{vj} = 25 °C		155		ns
			T_{vj} = 125 °C		700		ns
			T_{vj} = 175 °C		840		ns
Reverse recovery energy	E_{rec}		T_{vj} = 25 °C		27		mJ
			T_{vj} = 125 °C		43		mJ
			T_{vj} = 175 °C		55		mJ

Package properties[9]

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNIT
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$	Per switch				0.046	K/W
Diode thermal resistance junction to case	$R_{th(j-c)Diode}$					0.077	K/W
IGBT thermal resistance case to heatsink	$R_{th(c-s)IGBT}$	IGBT per switch			0.030		K/W
Diode thermal resistance case to heatsink	$R_{th(c-s)Diode}$	diode per switch			0.036		K/W
Comparative tracking index	CTI			200			
Module stray inductance	$L_{s\,CE}$	Per switch			20		nH
Resistance, terminal chip	$R_{CC'+EE'}$	Per switch	T_{vj} = 25 °C		0.9		mΩ
			T_{vj} = 125 °C		1.25		mΩ
			T_{vj} = 175 °C		1.4		mΩ

---

[7] Characteristic values according to IEC 60747-2

[8] Forward voltage is given at chip-level

[9] Package and mechanical properties according to IEC 60747-15

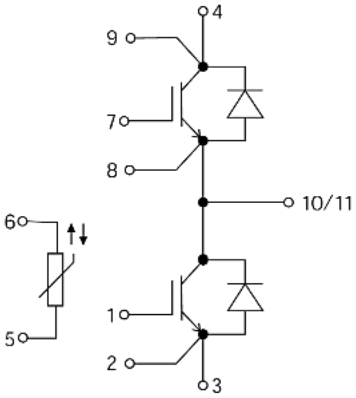
Mechanical properties

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNIT
Dimensions	L x W x H	Typical			152 x 62 x 17		mm^3
Clearance distance in air	d_a	According to IEC 60664-1 and EN 50124-1	Terminal to base:	12.5			mm
			Terminal to terminal:	10			mm
Surface creepage distance	d_s	According to IEC 60664-1 and EN 50124-1	Terminal to base:	14.5			mm
			Terminal to terminal:	13			mm
Mass	M				350		g

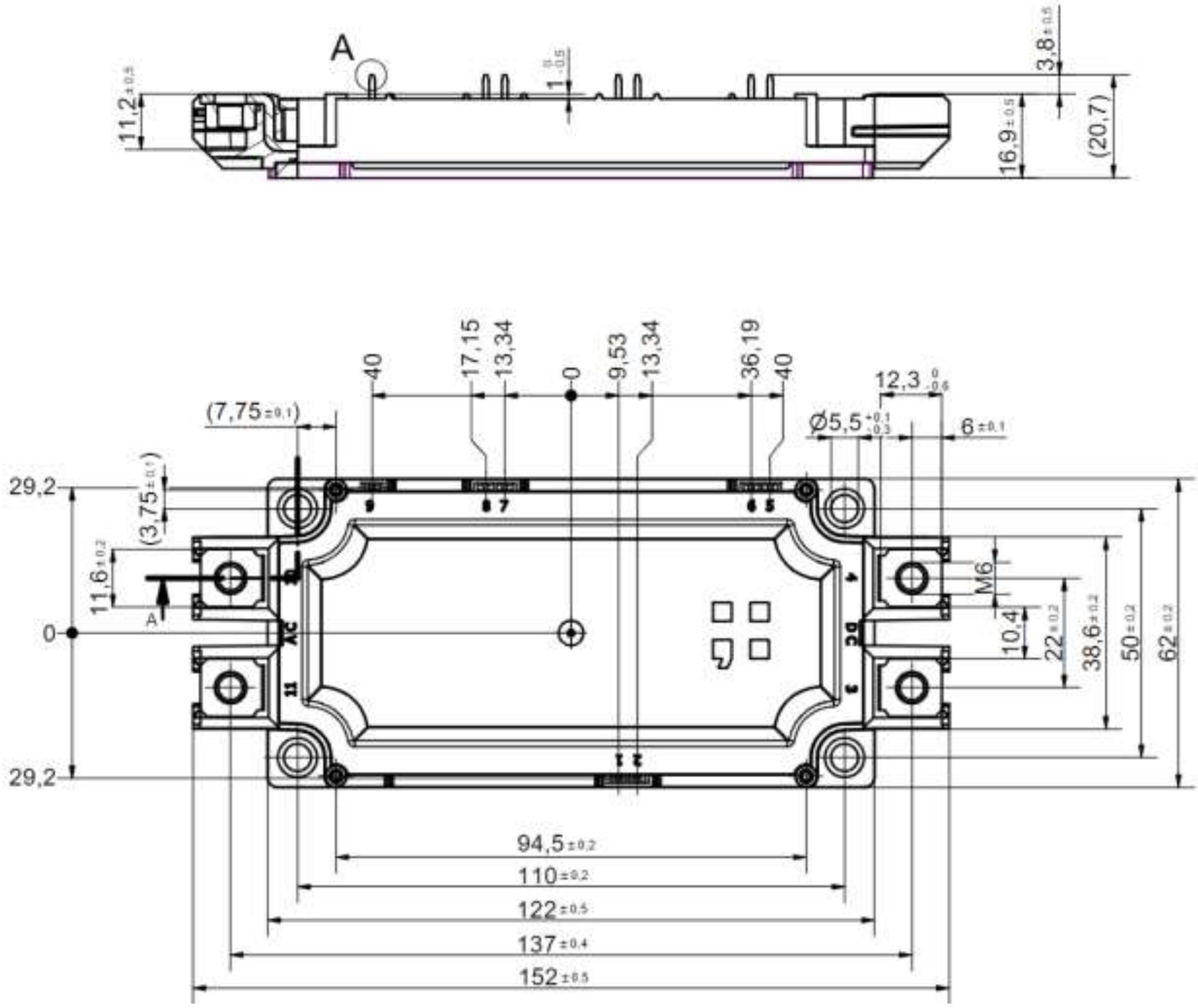
NTC Thermistor

PARAMETER	SYMBOL	CONDITIONS		TYP	MAX	UNIT
Rated resistance	R_{25}	T_C = 25 °C		5		kΩ
R100	R_{100}	T_C = 100 °C	468		518	Ω
B-value	$B_{25/50}$	$R_2 = R_{25} \exp [B_{25/50}(1/T2 - 1/(298.15K))]$		3375		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp [B_{25/100}(1/T2 - 1/(298.15K))]$		3433		K

Electrical configuration



Outline drawing



This is an electrocstatic sensitive device.

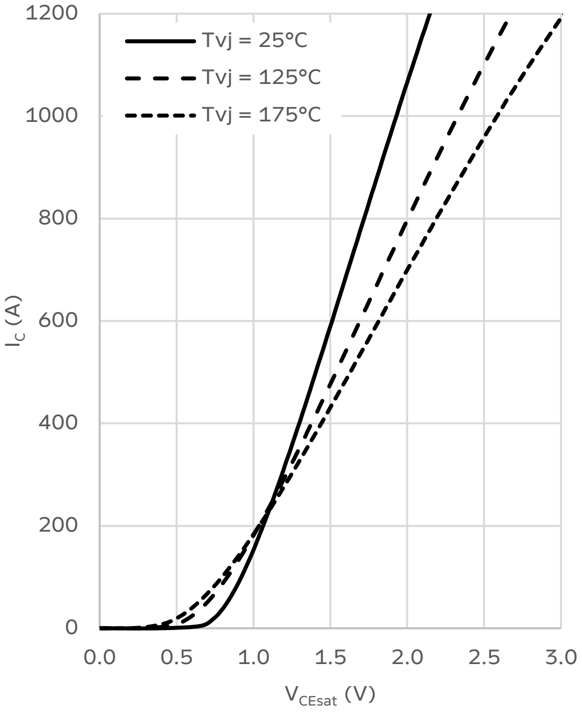
This product has been designed and qualified for Industrial Level.

Characteristics

IGBT on-state characteristics (typical)

$I_C = f(V_{CE})$

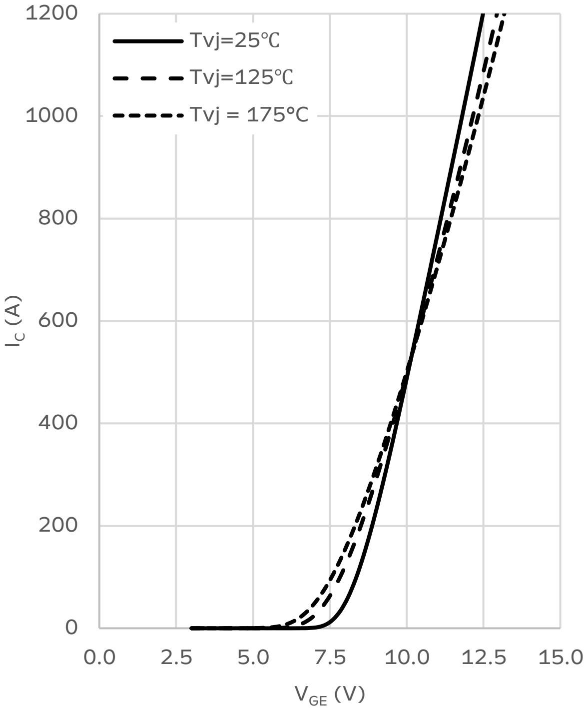
$V_{GE} = 15$ V



IGBT transfer characteristics (typical)

$I_C = f(V_{GE})$

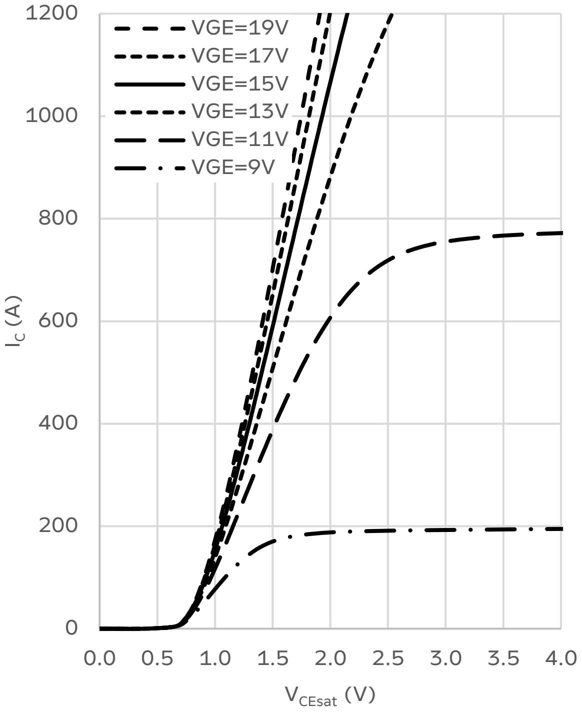
$V_{CE} = 20$V



IGBT output characteristics (typical)

$I_C = f(V_{CE})$

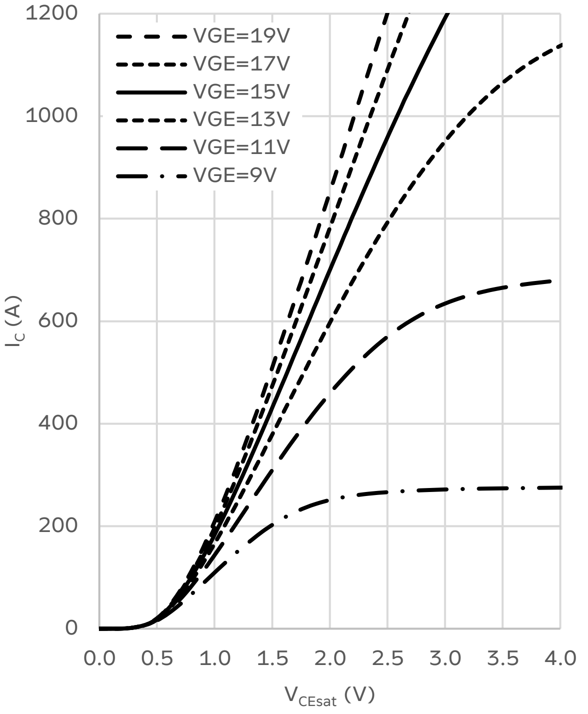
$T_{vj} = 25$ °C



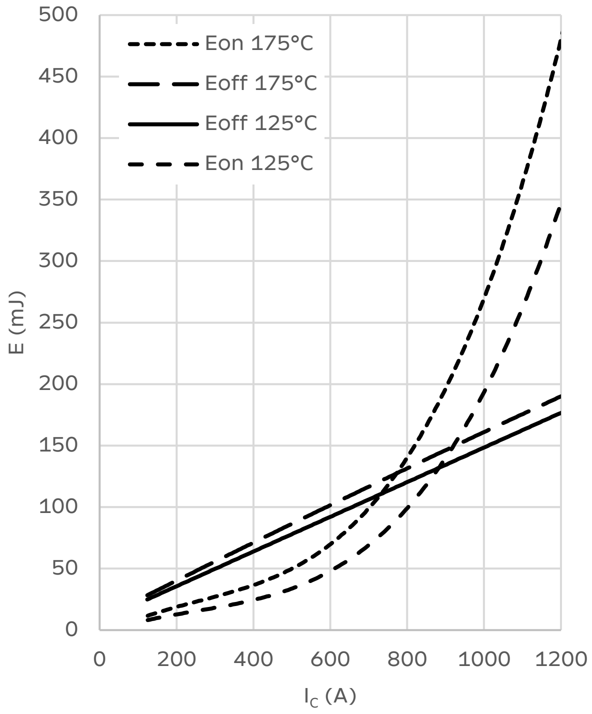
IGBT output characteristics (typical)

$I_C = f(V_{CE})$

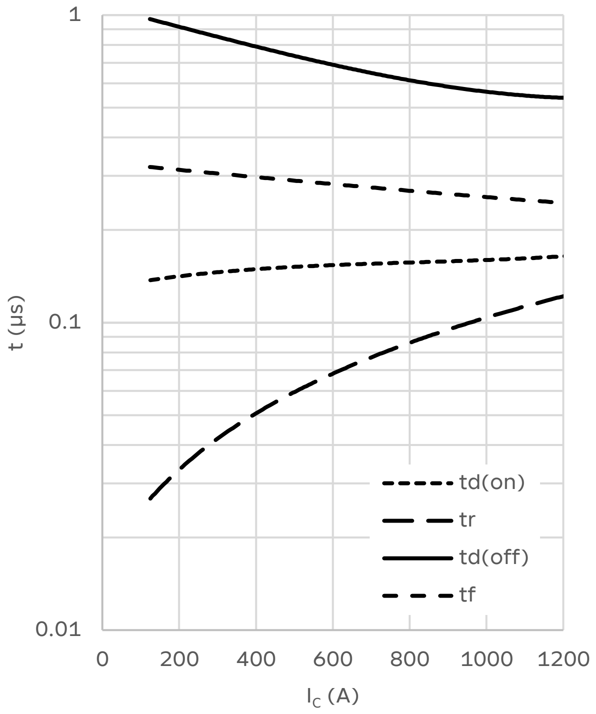
$T_{vj} = 175$ °C



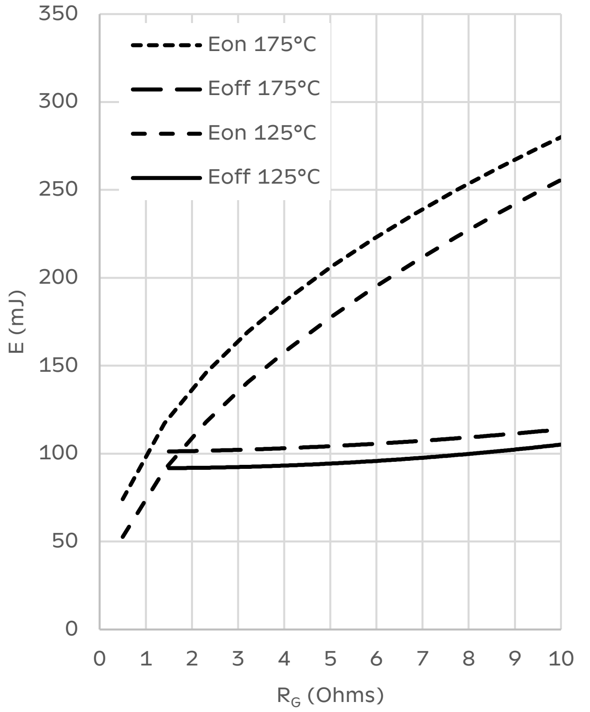
IGBT switching losses (typical)
E = f(I_{CE})
V_{CE} = 600 V, R_{Gon} = 0.47 Ω, R_{Goff} = 1.5 Ω, V_{GE} = -15/+15 V



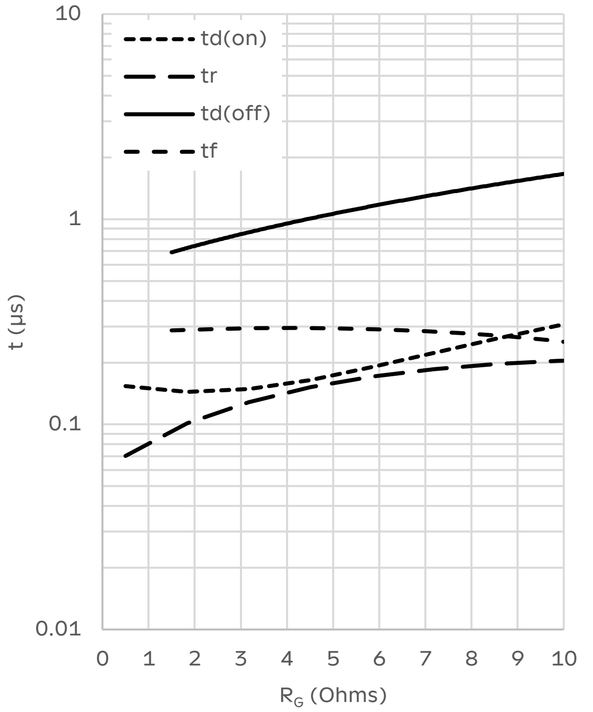
IGBT switching times (typical)
t = f(I_{CE}), T_{vj} = 175 °C
V_{CE} = 600 V, R_{Gon} = 0.47 Ω, R_{Goff} = 1.5 Ω, V_{GE} =-15/+15 V



IGBT switching losses (typical)
E = f(R_G)
V_{CE} = 600 V, I_C = 600 A, V_{GE} = -15/+15 V



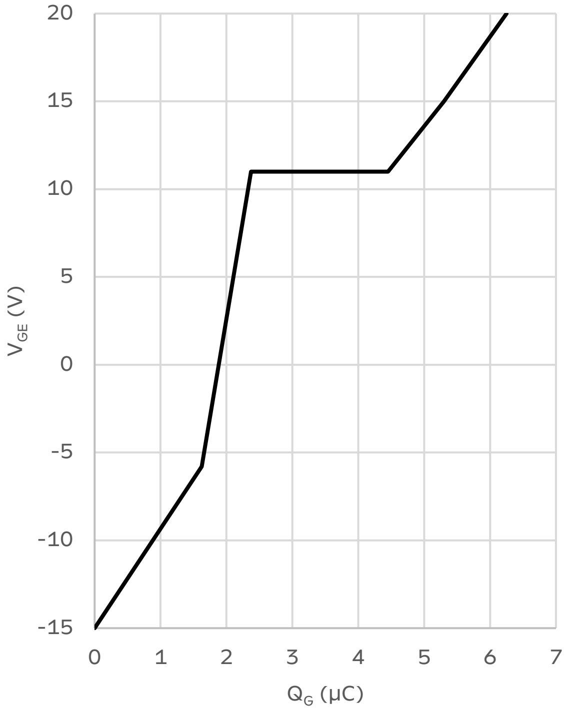
IGBT switching times (typical)
t = f(R_G), T_{vj} = 175 °C
V_{CE} = 600 V, I_C = 600 A, V_{GE} = -15/+15 V



IGBT gate charge (typical)

$V_{GE} = f(Q_G)$, $T_{vj} = 25$ °C

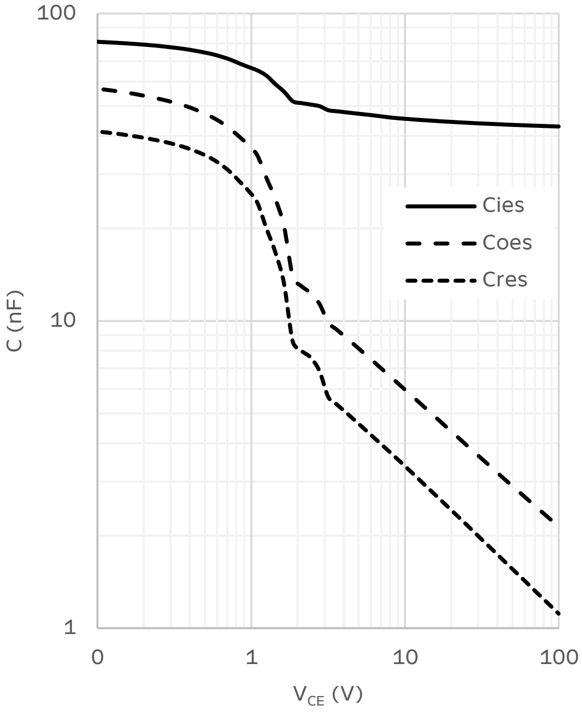
$V_{CE} = 600$ V, $I_C = 600$ A



Capacitance characteristics (typical)

$C = f(V_{CE})$, $T_{vj} = 25$ °C

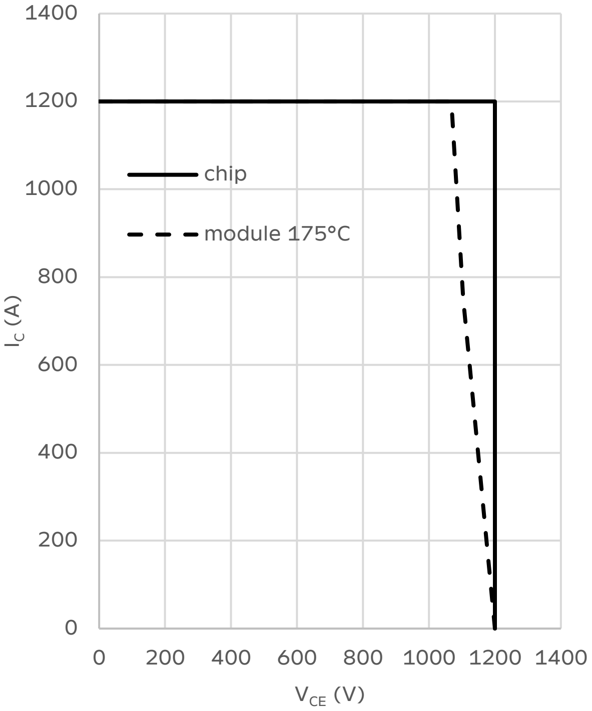
f = 100 kHz, $V_{GE} = 0$ V



IGBT RBSOA

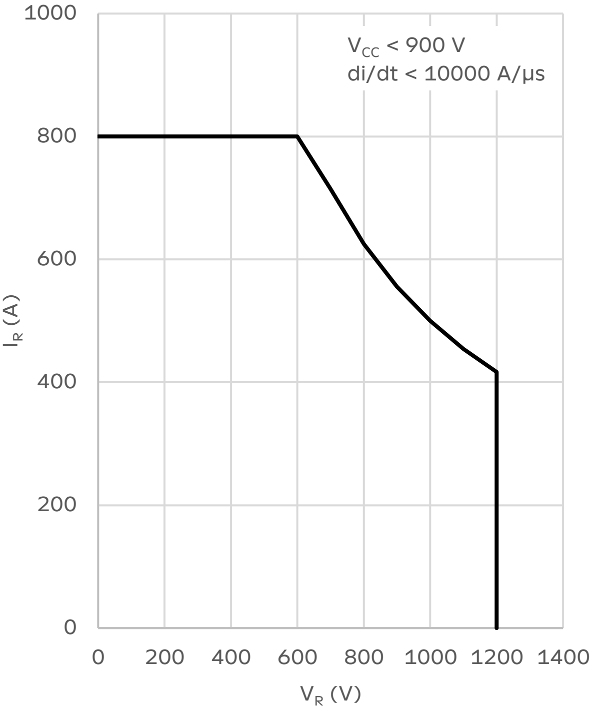
$I_C = f(V_{CEm})$

$R_{Goff} = 1.5\ \Omega$, $V_{GE} = \pm15$ V



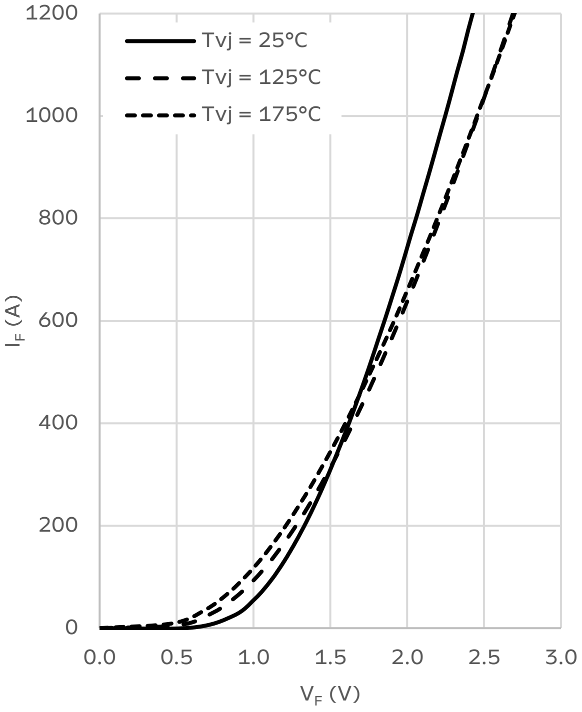
Diode SOA

$T_{vj} \leq 175$ °C



Diode forward characteristic (typical)

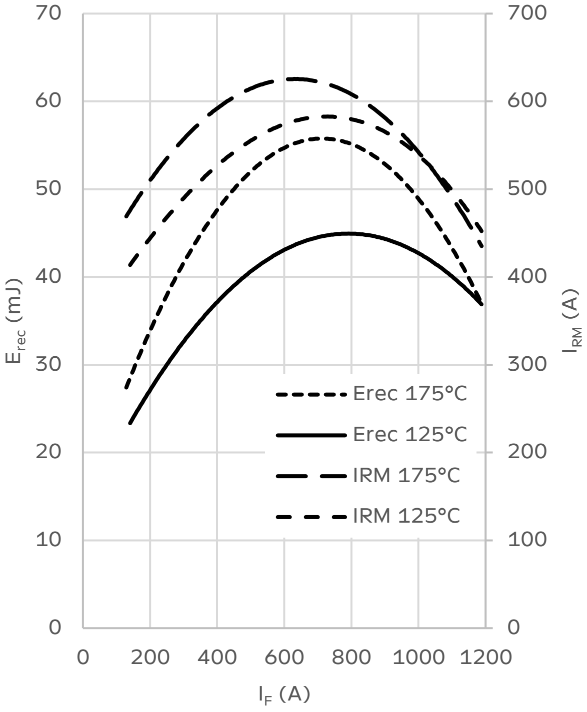
$I_F = f(V_F)$



Diode switching characteristics (typical)

$E_{rec} = f(I_F)$, $I_{RM} = f(I_F)$

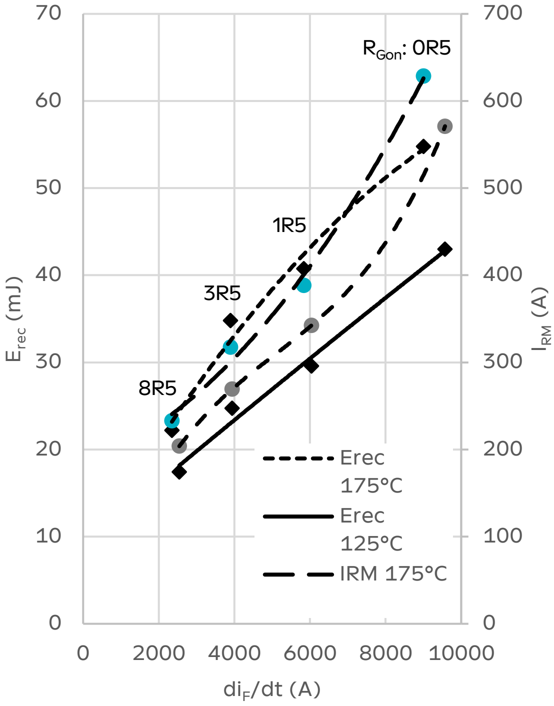
$V_{DC} = 600$ V, $R_{Gon} = 0.47\ \Omega$ (IGBT), $V_{GE} = -15/+15$ V (IGBT)



Diode switching characteristics (typical)

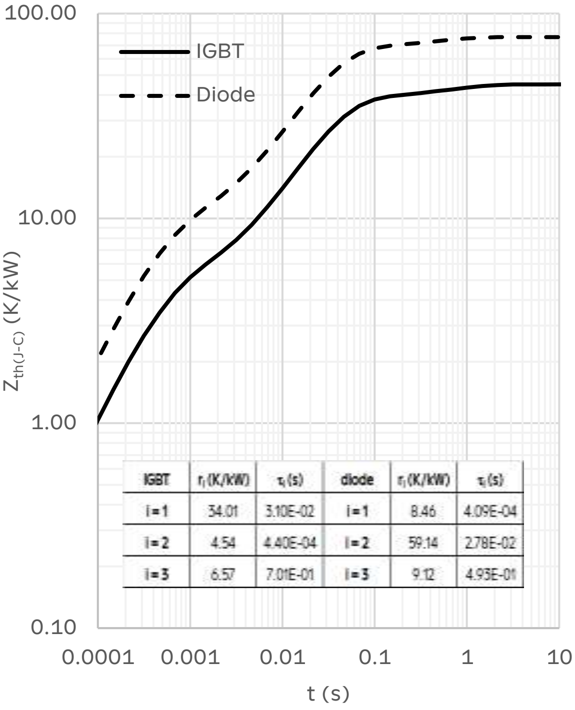
$E_{rec} = f(di/dt)$, $I_{RM} = f(di/dt)$

$V_{DC} = 600$ V, $I_F = 600$ A, $V_{GE} = -15/+15$ V (IGBT)



Thermal impedance

$Z_{th(j-c)} = f(t)$



IGBT	r_i (K/kW)	τ_i (s)	diode	r_i (K/kW)	τ_i (s)
i = 1	34.01	3.10E-02	i = 1	8.46	4.09E-04
i = 2	4.54	4.40E-04	i = 2	59.14	2.78E-02
i = 3	6.57	7.01E-01	i = 3	9.12	4.93E-01